

Search Notes

Application/Control No.

10/564,890

Examiner

James Mackey

Applicant(s)/Patent under
Reexamination

OGAWA, YUICHIRO

Art Unit

1722

SEARCHED

Class	Subclass	Date	Examiner
425	54, 55, 56, 57	6/11/2007	JPM
156	110.1	6/11/2007	JPM
above updated		9/26/07	JM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
425	54, 56	9/26/07	JM

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Conducted INVENTOR name search in IFW	6/11/2007	JPM